

Computer Architecture

计算机体系结构

Lecture 14. Design for Reliability/Availability

第十四讲、面向可靠性和可用性的设计

Chao Li, PhD.

李超 博士

SJTU-SE346, Spring 2019

Review

- G-States
- S-States
- C-States
- P-States
- TDP, Turbo Boost
- Power management can be challenging

Outlines

- Reliability and Availability
- Discussion and Case Studies

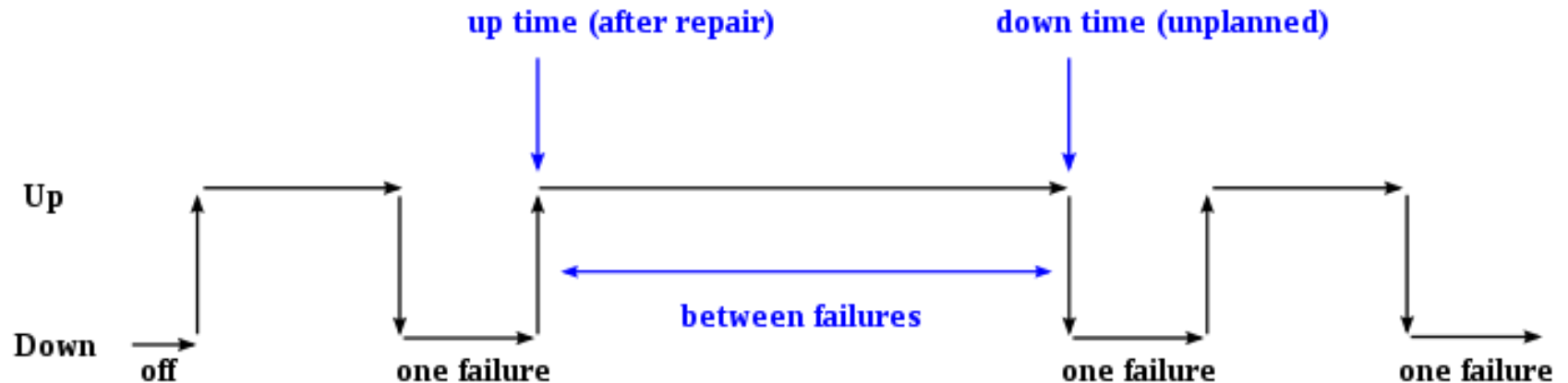
Faults, Errors, and Failures

- A **fault** is a physical flaw
 - e.g., a broken wire or a wear-out transistor
- A fault can manifest itself as an **error**
 - e.g. a bit that is a zero instead of a one
 - Fault can be masked and not manifest itself as any error
- An error can be masked or it can result in a **failure**
 - Failures are user-visible incorrect behavior

A **transient fault** occurs once and then does not persist
An error due to a transient fault is known as **soft error**

MTTF, MTBF, MTTR

- Mean Time to Failure (MTTF)
- Mean Time Between Failures (MTBF)
- Mean Time to Repair (MTTR)



Time Between Failures = { down time - up time }

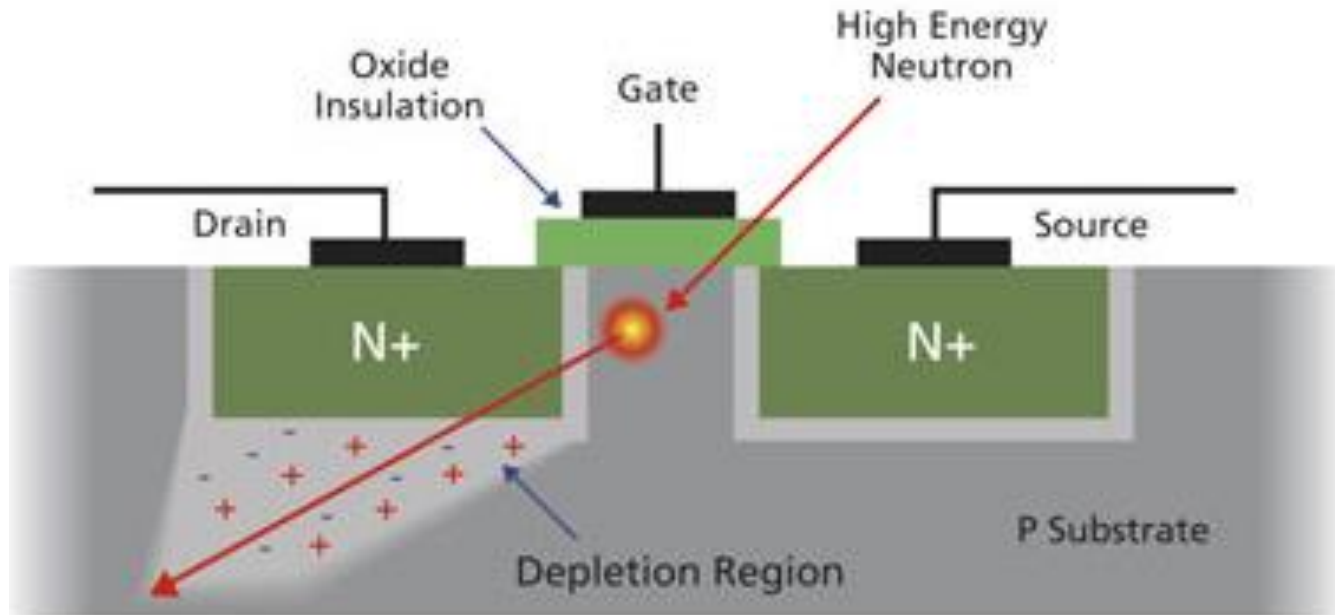
$$\text{Availability} = \frac{MTTF}{MTBF} = \frac{MTTF}{MTTF + MTTR}$$

Availability and Reliability

- The availability of a system at time t
 - is the probability that the system is operating correctly at time t .
 - units for availability are often the “number of nines”
- The reliability of a system at time t
 - is the probability that the system has been operating correctly from time zero until time t .

Is it possible for a low-reliability system to have high availability?

Discussion: ACE and AVF



- Architecturally correct execution (ACE) bit
 - Whose correctness is required for the correctness of the program
 - Un-ACE bits: those that are not critical to program correctness

Discussion: ACE and AVF

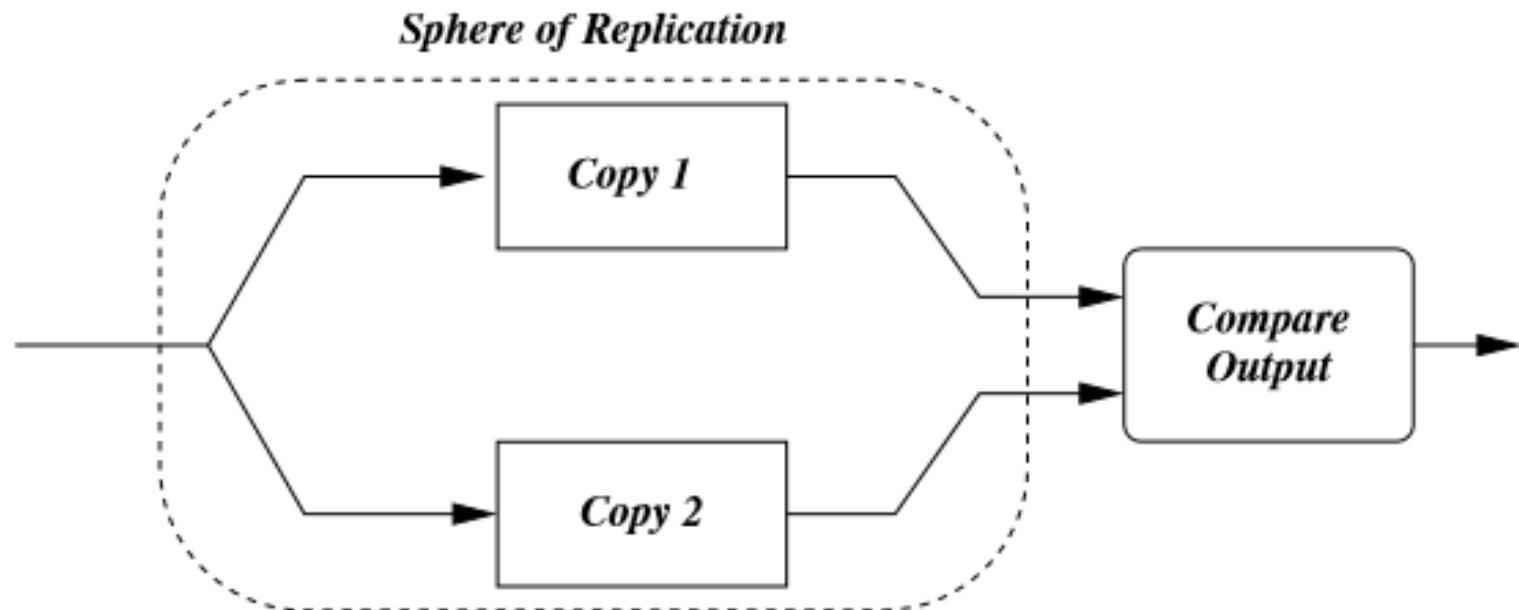
- Architectural vulnerability factor (AVF)
 - captures the probability that a fault in a structure will manifest as an error in the program output
- The AVF of a hardware structure H containing B bits over a period of N cycles can be expressed as:

$$AVF_{structure} = \frac{1}{N} \sum_{i=0}^N \left(\frac{\text{ACE bits in H at cycle } i}{B} \right)$$

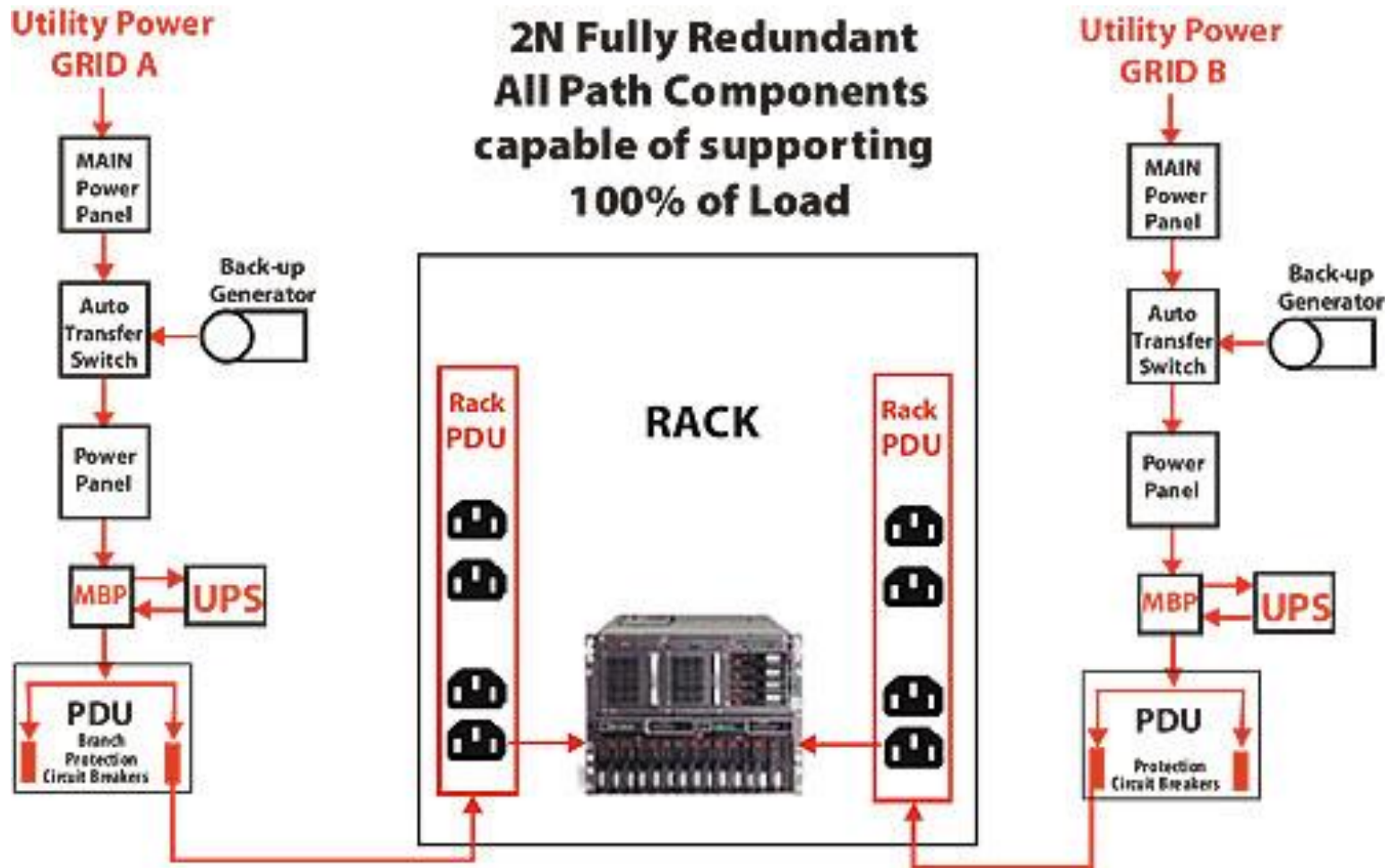
- Design considerations?
 - Appropriate microarchitecture + Application characteristics

Discussion: SMT for Fault Tolerance

- Two independent threads are created for every thread that the application wants to run
 - execute identical code and receive the same inputs
 - A divergence in output signals a fault



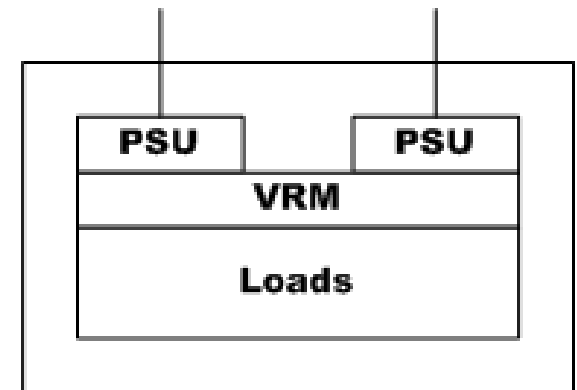
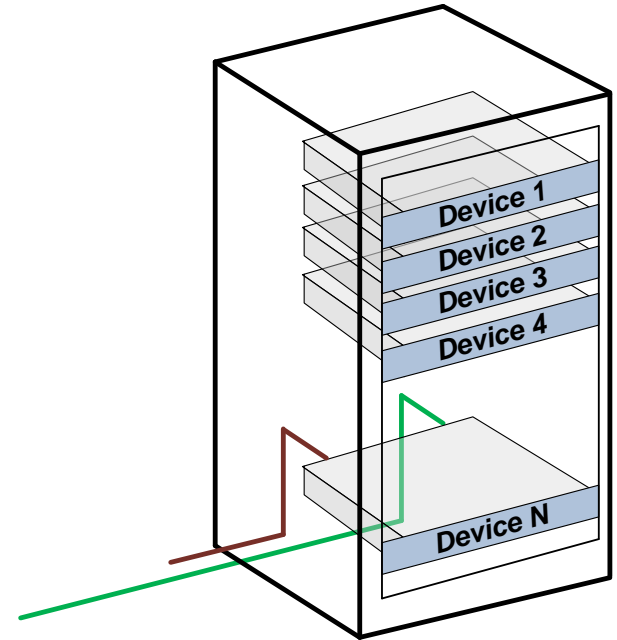
Redundancy: Power Delivery



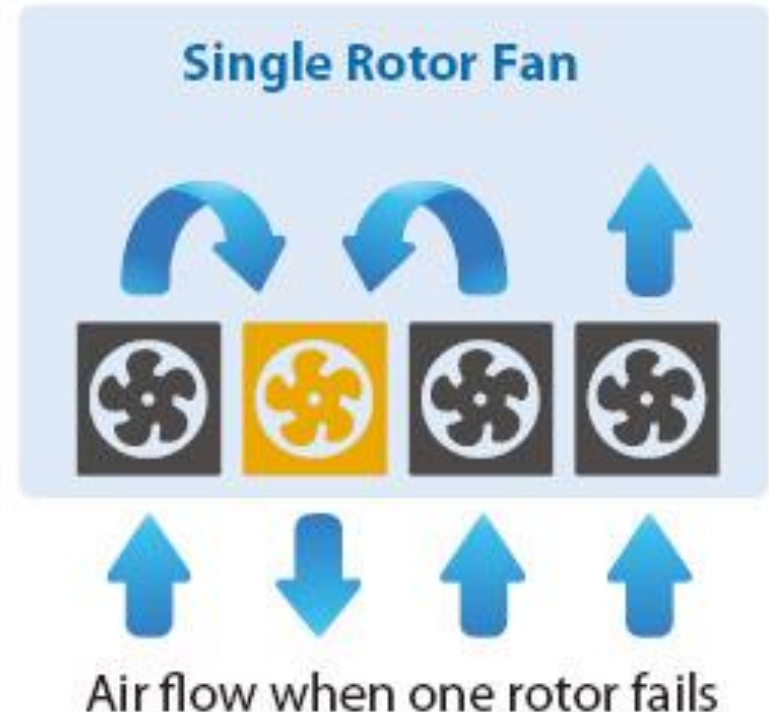
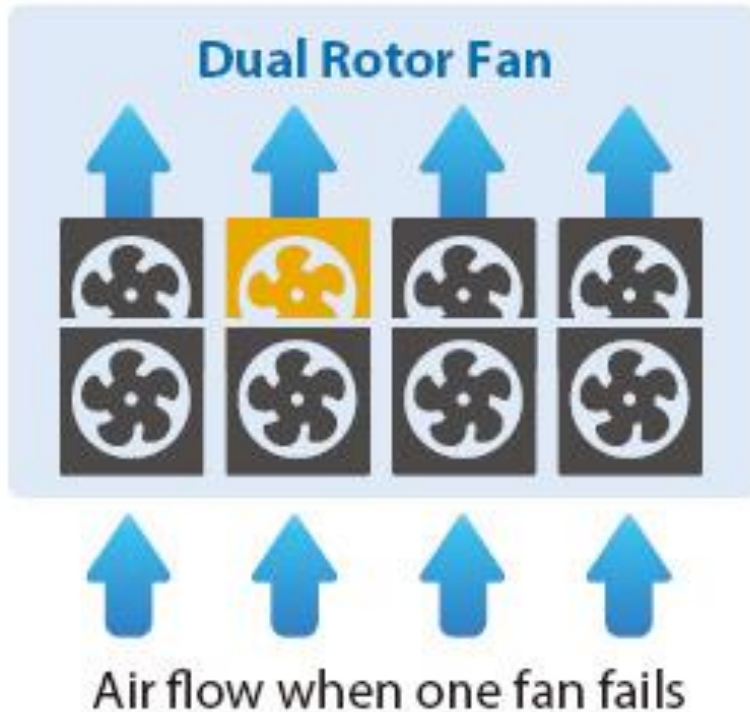
Dual Power Delivery Path + Dual-Corded Servers

Redundancy: Power Supply

- Dual-corded (双电缆)
 - Two PSU is employed for each server!
 - High availability
- Single-corded
 - Single PSU is employed
 - Can be seen in a dual path environment

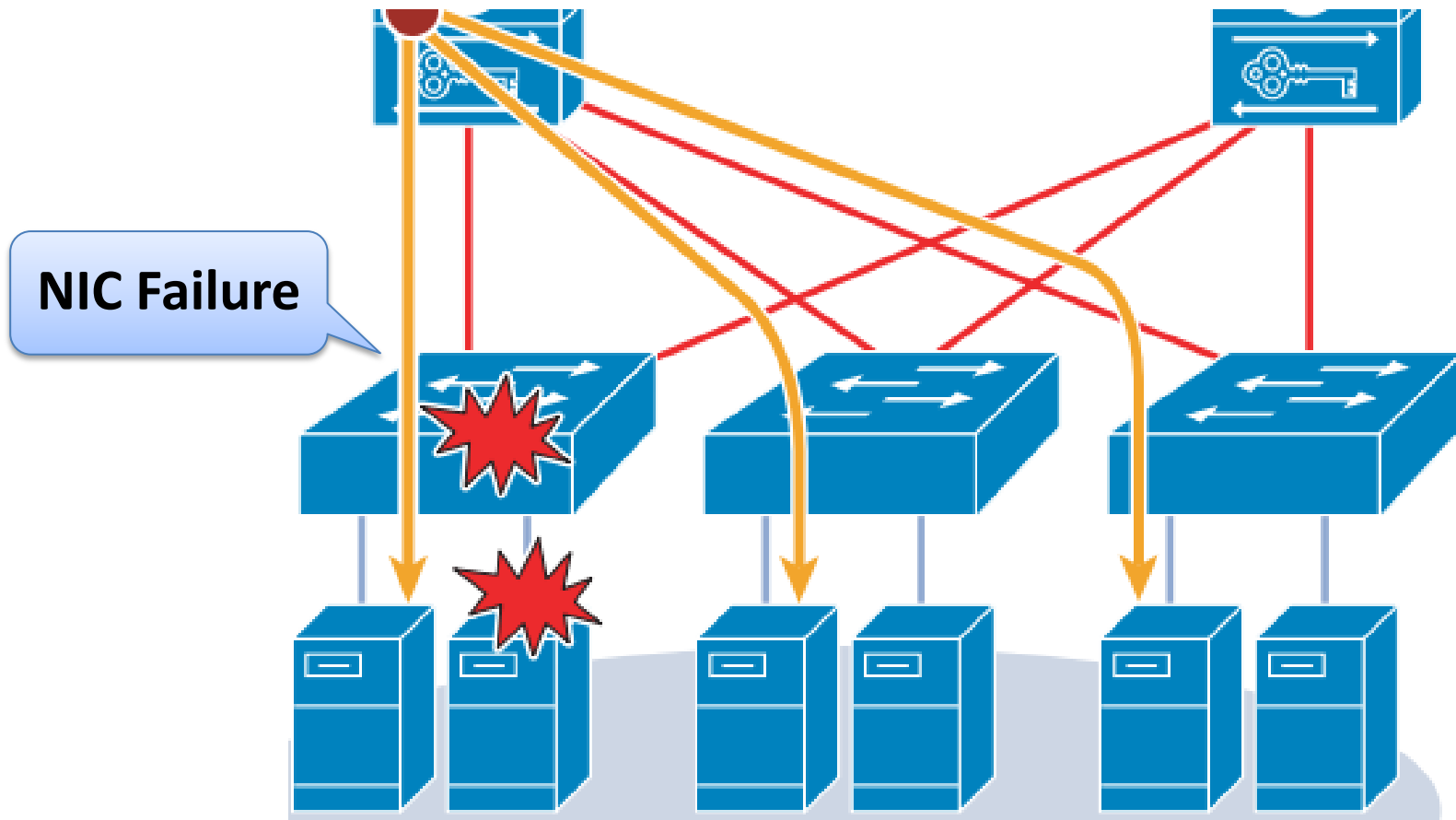


Redundancy: Cooling System



Dual Rotor Fan vs. Single Rotor Fan

Redundancy: Network System



Fault-Tolerant Load Balancing

Summary

- Faults, error, and failure
- MTTF, MTBF, MTTR
- Availability, reliability
- ACE, AVF
- Redundancy